

Notice of References Cited	Application/Control No. 10/588,103		Applicant(s)/Patent Under Reexamination MIURA, MINEO	
	Examiner FEI FEI YEUNG LOPEZ		Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0119076	06-2004	Ryu, Sei-Hyung	257/077
*	B	US-2004/0159886	08-2004	Lee et al.	257/331
	C	US-			
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FOREIGN PATENT DOCUMENTS

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